

<b>Search Notes</b>	<b>Application/Control No.</b>	<b>Applicant(s)/Patent Under Reexamination</b>
	10537786	FUTAMATA, HIROMASA
	<b>Examiner</b>	<b>Art Unit</b>
	Duong, Dieu Hien T	2821

### SEARCHED

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
343	700ms, 702, 767, 770	02/16/07	dd

### SEARCH NOTES

<b>Search Notes</b>	<b>Date</b>	<b>Examiner</b>
Please See East Search History	02/16/07	dd
Consulted with Tan Ho, primary 343	02/16/07	dd

### INTERFERENCE SEARCH

<b>Class</b>	<b>Subclass</b>	<b>Date</b>	<b>Examiner</b>
343	700ms,702,767,770	02/22/07	dd

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